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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)		Complete if Known			
		Application Number	10/654,790		
		Filing Date	9/4/03		
		First Named Inventor	Pan		
		Art Unit	2818		
		Examiner Name	M. Tran		
Sheet	1	of	5	Attorney Docket Number	

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
MH	1	J.L. PAN, J.E. McMANUS, L. GROBER and J.M. WOODWALL, Gallium-arsenide deep-level pin tunnel diode with very negative conductance, Electronics Letters, Sept. 18, 2003, Vol. 39 No. 19	
	2	JANET L. PAN, JOSEPH E.MCMANIS, THOMAS OSADCHY, LOUISE GROBER, JERRY M. WOODALL and PETER J. KINDLMANN, Gallium arsenide deep-level optical emitter for fibre optics, Nature Materials, June 2003, pp. 375-378, © 2003 Nature Publishing Group	
	3	JANET L. PAN, J.E. McMANIS, L. GROBER, J.M. WOODALL, Gallium-arsenide deep-level tunnel diode with record negative conductance and record peak current density, Solid-State Electronics 48, (2004), pp. 2067-2070, © 2004 Elsevier Ltd.	
	4	JANET L. PAN, Analytical method for finding the general optical properties of semiconductor deep centers, Journal of Applied Physics, Nov. 15, 2002, pp. 5991-6004, Volume 92, Number 10, © 2002 American Institute of Physics	
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	6	S. FUKUSHIMA, K. MUKAI, N. OTSUKA, X-ray diffraction analysis of LT-GaA's multilayer structures, Journal of Crystal Growth, 2002, pp. 1-5, © 2002 Published by Elsevier Science B.V.	
	7	G. M. MARTIN, M. L. VERHEIJKE and J.A.J. JANSEN, Measurement of the chromium concentration in semi-insulating GaAs using optical absorption, J. Appl. Phys. 50(1), Jan. 1979, pp. 467-471, © 1979 American Institute of Physics	
	8	J. SERRANO, A. WYSMOLEK, T. RUF, M. CARDONA, Spin-orbit splitting of acceptor states in Si and C, Physica B. 273-641 (1999), pp. 640-643, © 1999 Elsevier Science B.V.	
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**INFORMATION DISCLOSURE
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<i>MT</i>	11	PETER C. SERCEL, AL. L. EFROS and M. ROSEN, Intrinsic Gap States in Semiconductor Nanocrystals, Physical Review Letters, Sept. 20, 1999, pp. 2394-2397, Volume 83, Number 12, © 1999 The American Physical Society	
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	13	J.C. BOURGOIN, H. HAMMADI, M. STELLMACHER, J. NAGLE, B. GRANDIDIER, D. STIEVENARD, J.P. NYS, C. DELERUE, M. LANNOO, As antisite incorporation in epitaxial growth of GaAs, Physica B 273-274, 1999, pp. 725-728, © 1999 Elsevier Science B.V.	
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	20	T. OBATA, S. FUKUSHIMA, T. ARAYA, N. OTSUKA, Photoluminescence of nearly stoichiometric LT-GaAs and LT-GaAs/AlAs MQW, Journal of Crystal Growth 227-228 (2001), pp. 112-116, © 2001 Elsevier Science B.V.	

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MH	21	JUN-YUAN CHEN, JENN-GEE LO and LUKE SU LU, Optical Transitions via the Structure-Defect Levels Due to Lattice Vacancies in InSb, Japanese Journal of Applied Physics, June 1991, pp. 1169-1175, Vol. 30, No. 6	
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	27	JEROME FAIST, FEDERICO CAPASSO, CARLO SIRTORI, DEBBIE SIVCO, ALBERT L. HUTCHINSON, SUNG-NEE G. CHU and ALFRED Y. CHO, Mid-infrared field-tunable intersubband electroluminescence at room temperature by photon-assisted tunneling in couple-quantum wells, Appl. Phys. Lett. 64 (9), Feb. 28, 1994, pp. 1144-1146, © 1994 American Institute of Physics	
	28	B. GRANDIDIER, HUAJIE CHEN, and R.M. FEENSTRA; D.T. MCINTURFF; P.W. JUODAWLKIS and S.E. RALPH, Scanning tunneling microscopy and spectroscopy of arsenic antisites in low temperature grown InGaAs, Applied Physics Letters, Mar. 8, 1999, pp. 1439-1441, Volume 74, Number 10, © 1999 American Institute of Physics	
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	30	R.M. FEENSTRA, Cross-sectional scanning tunnelling microscopy of III-V semiconductor structures, Semicond. Sci. Technol. 9, 1994, pp. 2157-2168, © 1994 IOP Publishing Ltd. (Printed in UK)	

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MA	31	G.M. MARTIN, Optical assesment of the main electron trap in bulk semi-insulating GaAs, Appl. Phys. Lett 39(9), Nov. 1, 1981, pp. 747-748, © 1981 American Institute of Physics		
	32	R. ERRIQUE VITURRO, MICHAEL R. MELLOCH, JERRY M. WOODALL, Optical emission properties of semi-insulating GaAs grown at low temperatures by molecular beam epitaxy, Appl Phys. Lett. 60(24), June 15, 1992, pp. 3007-3009, © 1992 Aerican Institttue of Physics		
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	41	SOKRATES T. PANTELIDES, The electronic structure of impurities and other point defects in semiconductors, Reviews of Modern Physics, Oct. 1978, pp. 797-858, Vol. 50, No. 4, © 1978 American Physical Society		
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	45	G. BREMOND, G. GUILLOT et A. NOUAILHAT, Spectres de sections efficaces absolues de photo-ionisation des ions de transition 3d dans Inp, Revue Phys. Appl. 22 (1987), pp. 873-879		
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